优尚

YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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Product Summary

$V_{(BR)DSS}$	$R_{DS(on)}$	I_D T_A = +25℃
60V	66mΩ @ V_{GS} = 10V	5.0A
	97mΩ @ V_{GS} = 4.5V	4.1A

Features and Benefits

- Low on-resistance
- Fast switching speed

Description and Applications

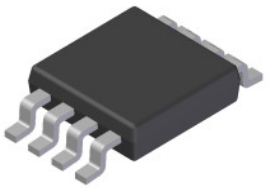
This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor Control
- Backlighting
- DC-DC Converters
- Power Management Functions

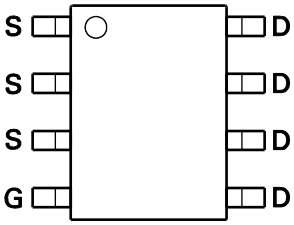
Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, “Green” Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram Below
- Terminals: Finish – Tin Finish Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (Approximate)

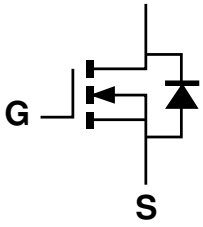
SO-8



Top View



Top View



Equivalent Circuit

Maximum Ratings (@T_A = +25℃, unless otherwise specified.)

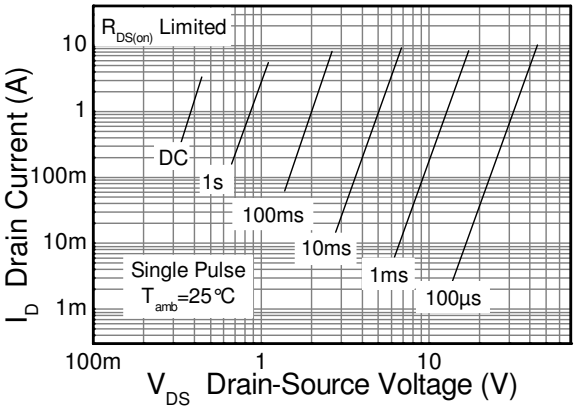
Drain-Source Voltage			V	60	V
Gate-Source Voltage		(Note 6)	V	±20	V
Single Pulsed Avalanche Energy		(Note 11)	E	37.5	mJ
Single Pulsed Avalanche Current		(Note 11)	I	5.0	A
Continuous Drain Current	V_{GS} = 10V	(Note 8)	I_D	5.0	A
		T = +70℃ (Note 8)		4.0	
		(Note 7)		3.7	
Pulsed Drain Current	V = 10V	(Note 9)	I	23	A
Continuous Source Current (Body diode)		(Note 8)	I	4.0	A
Pulsed Source Current (Body diode)		(Note 9)	I	23	A

Thermal Characteristics (@T_A = +25℃, unless otherwise specified.)

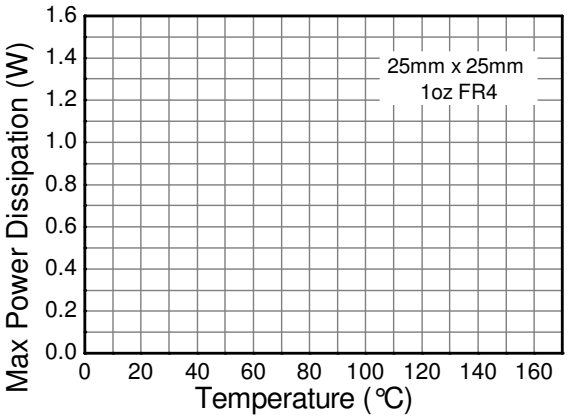
Power Dissipation	(Note 7)	P_D	1.56	W
Linear Derating Factor			12.5	mW/℃
	(Note 8)		2.81	W
			22.5	mW/℃
Thermal Resistance, Junction to Ambient	(Note 7)	$R_{\theta JA}$	80.0	℃/W
	(Note 8)		44.5	
Thermal Resistance, Junction to Lead	(Note 10)	R	37.0	
Operating and Storage Temperature Range		T , T	-55 to 150	℃

Notes:
6. AEC-Q101 V_{GS} maximum is ±16V.
7. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
8. Same as note (7), except the device is measured at t ≤ 10 sec.
9. Same as note (7), except the device is pulsed with D= 0.02 and pulse width 300 μs. The pulse current is limited by the maximum junction temperature.
10. Thermal resistance from junction to solder-point (at the end of the drain lead).
11. UIS in production with L = 3.0mH, I_{AS} = 5.0A, R_G = 25Ω, V_{DD}=50V, starting T_J = +25℃.

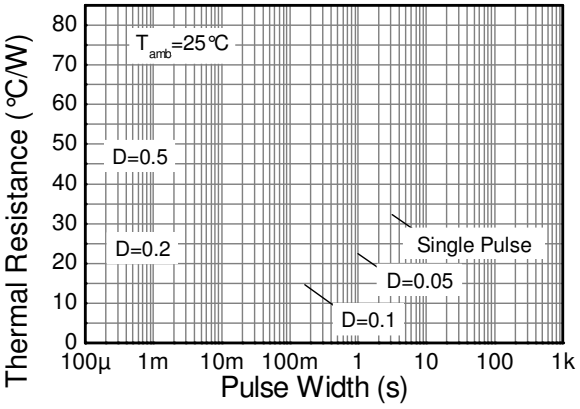
Thermal Characteristics



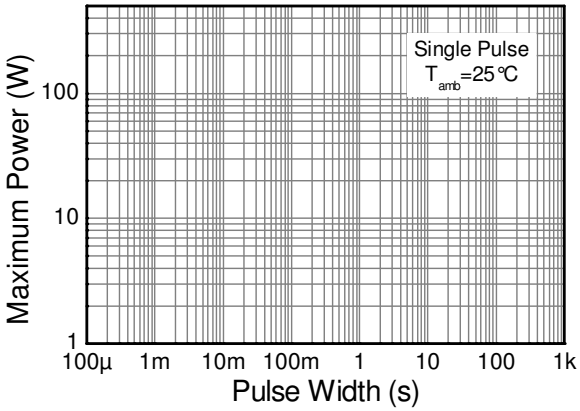
Safe Operating Area



Derating Curve



Transient Thermal Impedance



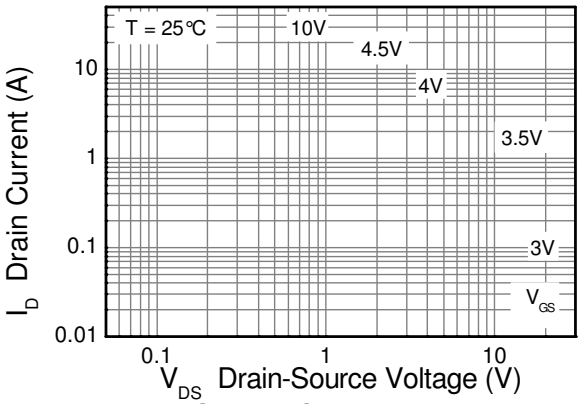
Pulse Power Dissipation

Electrical Characteristics (@T_A = +25℃, unless otherwise specified.)

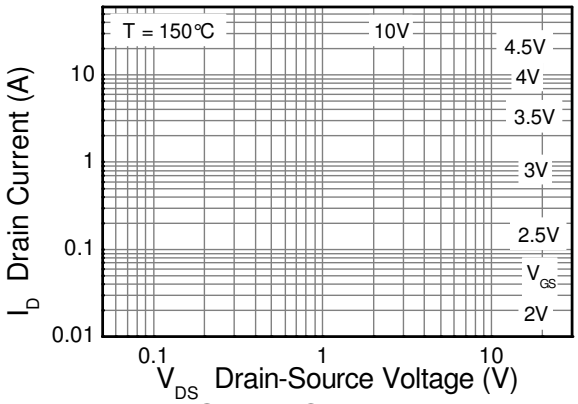
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	60	—	—	V	I_D = 250μA, V_{GS} = 0V
Zero Gate Voltage Drain Current	I_{DSS}	—	—	0.5	μA	V_{DS} = 60V, V_{GS} = 0V
Gate-Source Leakage	I_{GSS}	—	—	±100	nA	V_{GS} = ±20V, V_{DS} = 0V
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	1.0	—	3.0	V	I_D = 250μA, V_{DS} = V_{GS}
Static Drain-Source On-Resistance (Note 12)	$R_{DS\ (ON)}$	—	0.048	0.066	Ω	V_{GS} = 10V, I_D = 4.5A
			0.068	0.097		V_{GS} = 4.5V, I_D = 3.5A
Forward Transconductance (Notes 12 & 13)	g_{fs}	—	19.2	—	S	V_{DS} = 15V, I_D = 6A
Diode Forward Voltage (Note 12)	V_{SD}	—	0.89	1.15	V	I_S = 4.5A, V_{GS} = 0V
Reverse Recovery Time (Note 13)	t_{rr}		23	—	ns	I_S = 2.4A, di/dt = 100A/μs
Reverse Recovery Charge (Note 13)	Q_{rr}	—	19.7	—	nC	
DYNAMIC CHARACTERISTICS (Note 13)						
Input Capacitance	C_{iss}	—	502	—	pF	V_{DS} = 30V, V_{GS} = 0V f = 1MHz
Output Capacitance	C_{oss}	—	45.7	—	pF	
Reverse Transfer Capacitance	C_{rss}	—	27.1	—	pF	
Total Gate Charge (Note 14)	Q_g	—	5.4	—	nC	V_{GS} = 4.5V V_{DS} = 30V I_D = 4.5A
Total Gate Charge (Note 14)	Q_g	—	10.3	—	nC	V_{GS} = 10V
Gate-Source Charge (Note 14)	Q_{gs}	—	1.7	—	nC	
Gate-Drain Charge (Note 14)	Q_{gd}	—	3.2	—	nC	
Turn-On Delay Time (Note 14)	$t_{D(on)}$	—	2.7	—	ns	V_{DD} = 30V, V_{GS} = 10V I_D = 1A, $R_G \cong$ 6.0Ω
Turn-On Rise Time (Note 14)	t_r	—	2.4	—	ns	
Turn-Off Delay Time (Note 14)	$t_{D(off)}$	—	14.7	—	ns	
Turn-Off Fall Time (Note 14)	t_f	—	5.4	—	ns	

Notes:
12. Measured under pulsed conditions. Pulse width ≤ 300μs; duty cycle ≤ 2%.
13. For design aid only, not subject to production testing.
14. Switching characteristics are independent of operating junction temperatures.

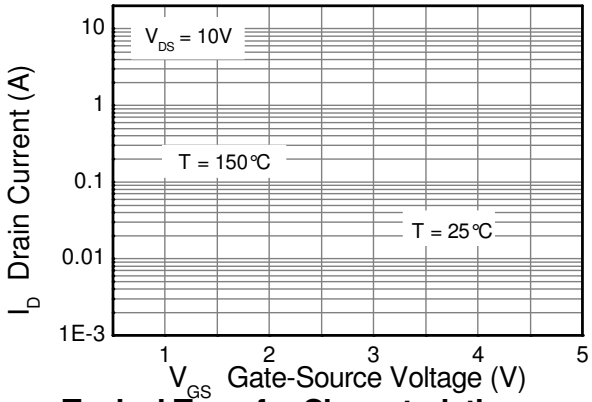
Typical Characteristics



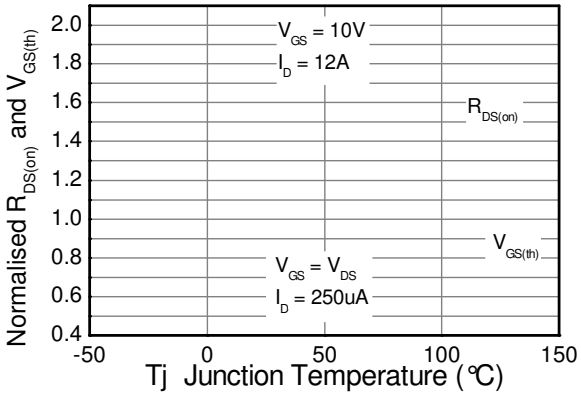
Output Characteristics



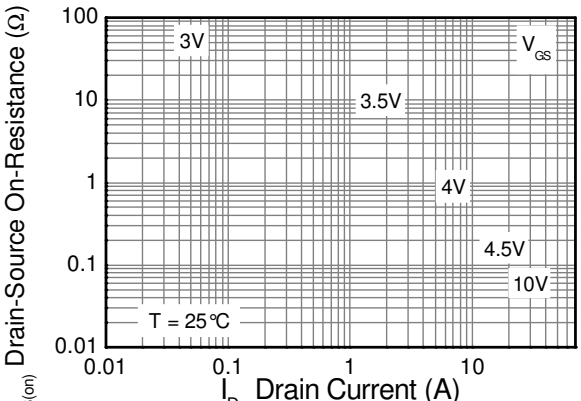
Output Characteristics



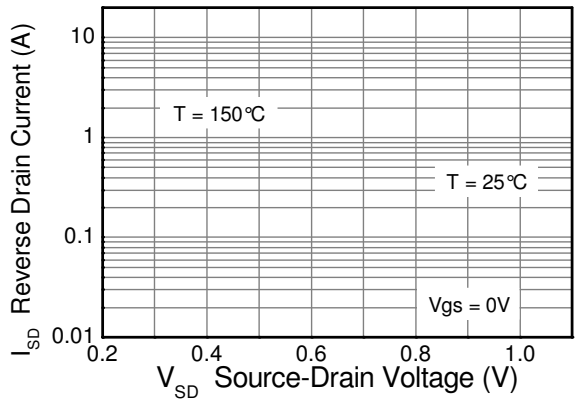
Typical Transfer Characteristics



Normalised Curves v Temperature

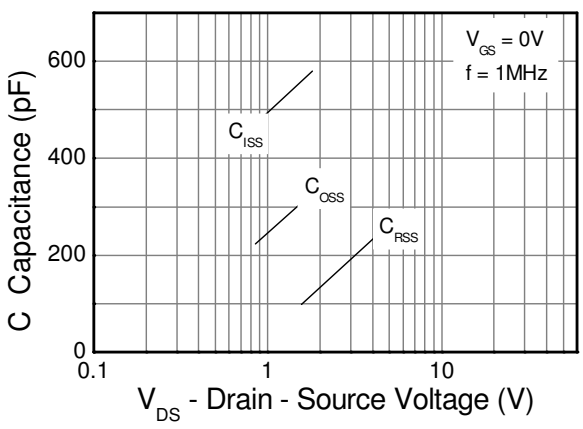


On-Resistance v Drain Current

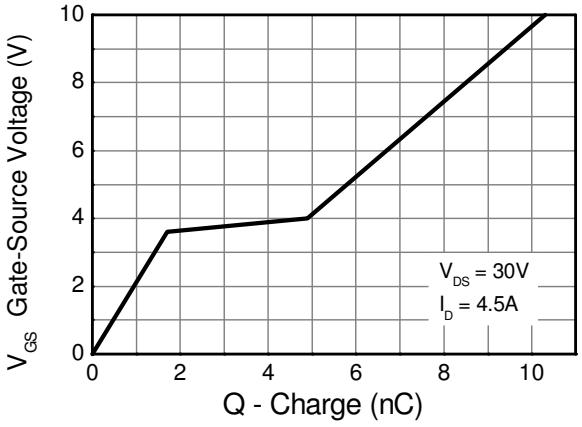


Source-Drain Diode Forward Voltage

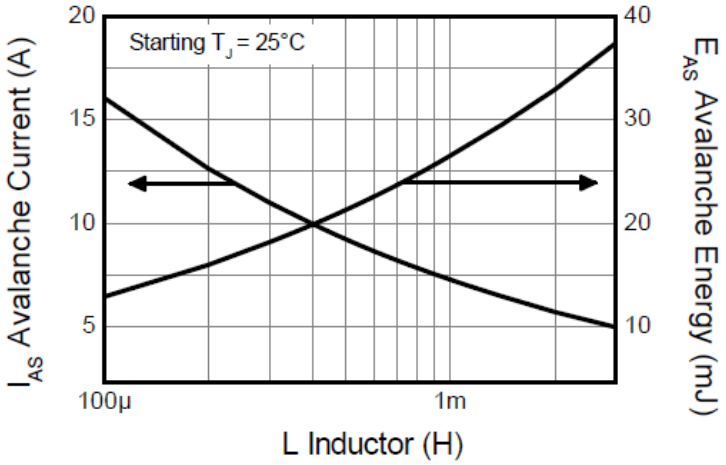
Typical Characteristics (continued)



Capacitance v Drain-Source Voltage

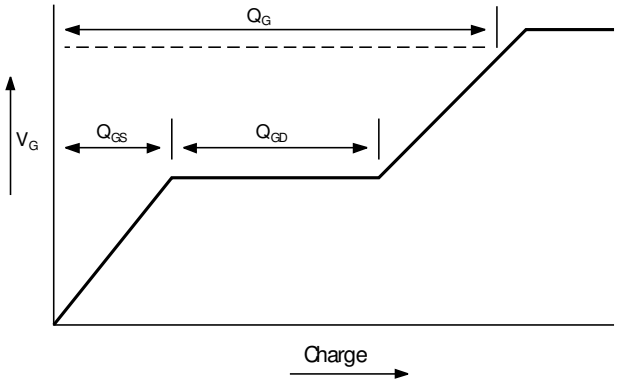


Gate-Source Voltage v Gate Charge

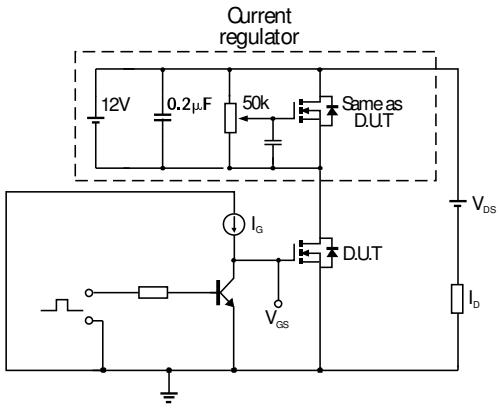


Single-Pulsed Avalanche Rating

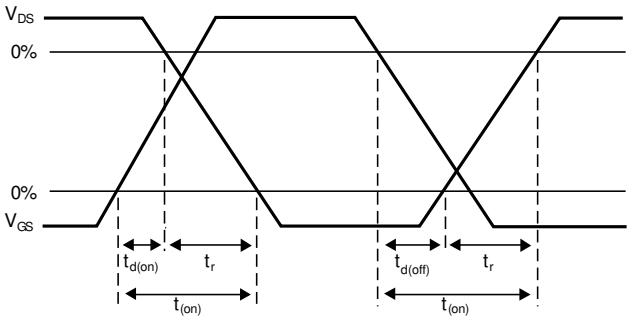
Test Circuits



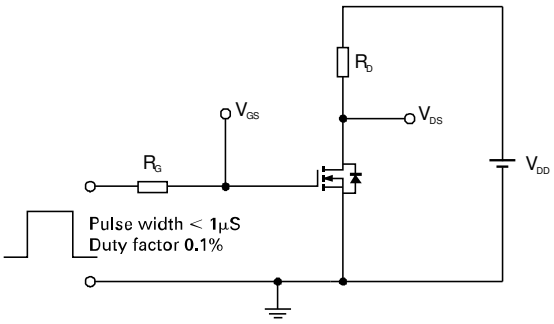
Basic gate charge waveform



Gate charge test circuit

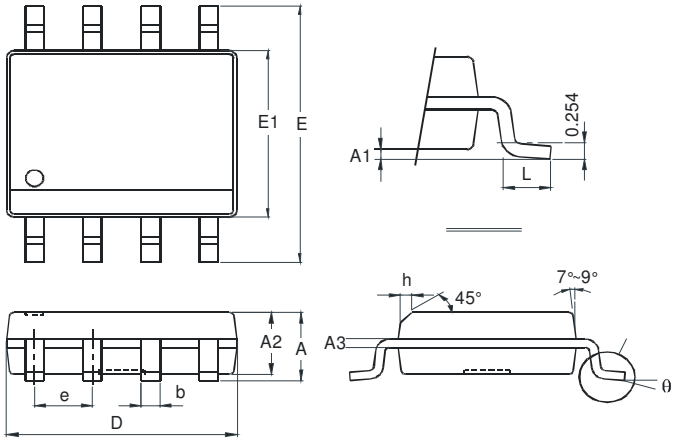


Switching time waveforms



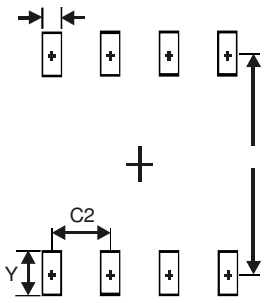
Switching time test circuit

Package Outline Dimensions



	-	1.75
	0.10	0.20
	1.30	1.50
	0.15	0.25
	0.3	0.5
	4.85	4.95
	5.90	6.10
	3.85	3.95
	1.27 Typ	
	-	0.35
	0.62	0.82
	0°	8°

Suggested Pad Layout



	0.60
	1.55
	5.4
	1.27